

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/549,783	SUN, BRIAN	
Examiner Robert Scruggs		Art Unit 3723	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0126953	07-2003	Kushner, Robert G.	81/3.45
*	B	US-7,069,825	07-2006	Cheung, Chun Ming	81/337
*	C	US-7,069,813	07-2006	Cheung, Chun Ming	81/3.37
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 20219538	4/2003		Warbeg	
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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Examiner ROBERT SCRUGGS		Art Unit 3723	Page 1 of 1	

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Examiner Robert Scruggs		Art Unit 3723	Page 1 of 1	

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Examiner Robert Scruggs		Art Unit 3723	Page 1 of 1	

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